

SDLS103

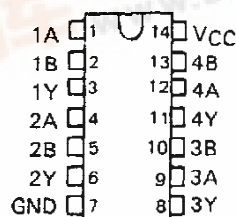
# SN5437, SN54LS37, SN54S37, SN7437, SN74LS37, SN74S37 QUADRUPLE 2-INPUT POSITIVE-NAND BUFFERS

DECEMBER 1983—REVISED MARCH 1988

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

SN5437, SN54LS37, SN54S37 . . . J OR W PACKAGE  
SN7437 . . . N PACKAGE  
SN74LS37, SN74S37 . . . D OR N PACKAGE

(TOP VIEW)



## description

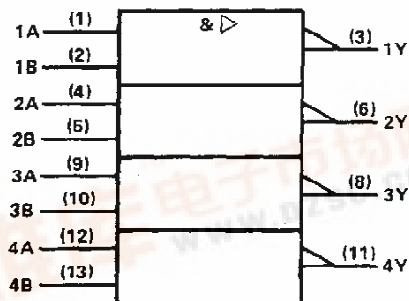
These devices contain four independent 2-input NAND buffer gates.

The SN5437, SN54LS37 and SN54S37 are characterized for operation over the full military range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN7437, SN74LS37 and SN74S37 are characterized for operation from  $0^{\circ}\text{C}$  to  $70^{\circ}\text{C}$ .

FUNCTION TABLE (each gate)

INPUTS		OUTPUT
A	B	Y
H	H	L
L	X	H
X	L	H

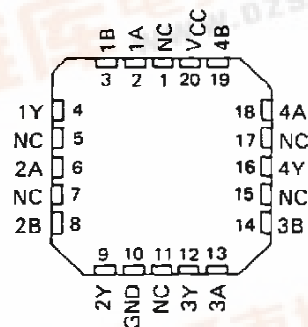
## logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

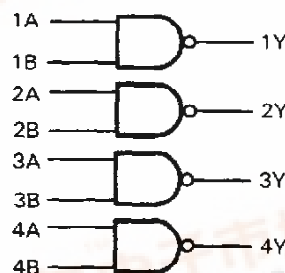
Pin numbers shown are for D, J, N, and W packages.

SN54LS37, SN54S37 . . . FK PACKAGE  
(TOP VIEW)



NC - No internal connection

## logic diagram

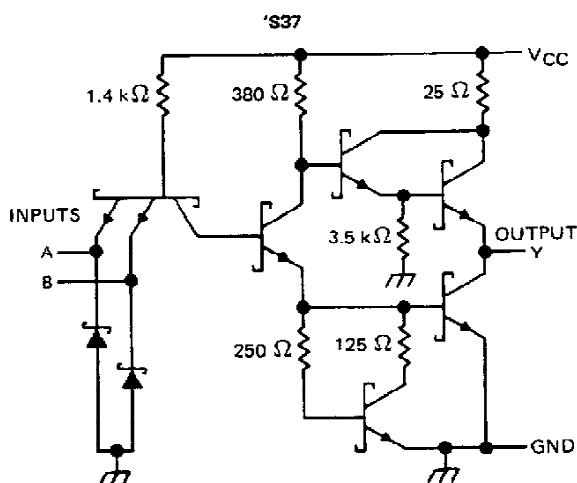
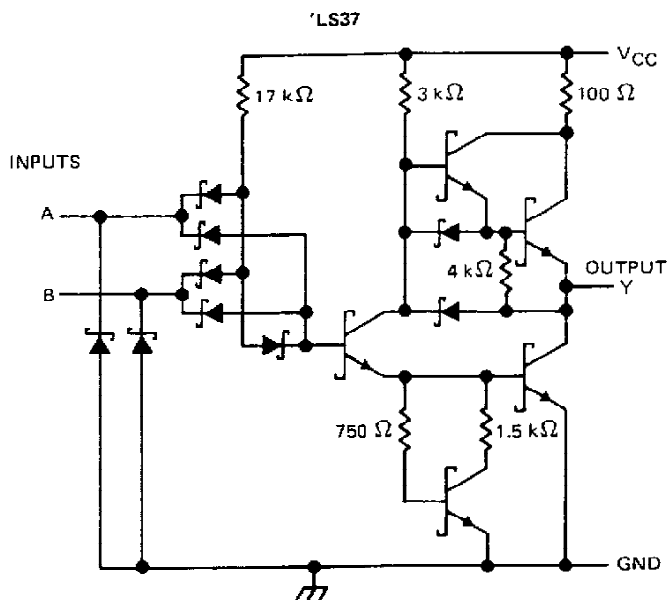
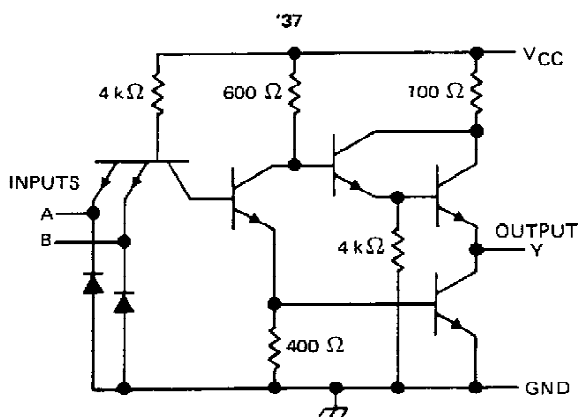


## positive logic

$$Y = \overline{A \cdot B} \text{ or } Y = \overline{A} + \overline{B}$$

**SN5437, SN54LS37, SN437  
SN7437, SN74LS37, SN7437  
QUADRUPLE 2-INPUT POSITIVE-NAND BUFFERS**

schematics (each gate)



Resistor values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, $V_{CC}$ (see Note 1)	7 V
Input voltage: '37, 'S37	5.5 V
'LS37	7 V
Operating free-air temperature: SN54'	-55°C to 125°C
SN74'	0°C to 70°C
Storage temperature range	-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

**TEXAS  
INSTRUMENTS**

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# **SN5437, SN7437** **QUADRUPLE 2-INPUT POSITIVE-NAND BUFFERS**

## **recommended operating conditions**

	SN5437			SN7437			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
$V_{CC}$ Supply voltage	4.5	5	5.5	4.75	5	5.25	V
$V_{IH}$ High-level input voltage	2			2			V
$V_{IL}$ Low-level input voltage			0.8			0.8	V
$I_{OH}$ High-level output current			-1.2			-1.2	mA
$I_{OL}$ Low-level output current			48			48	mA
$T_A$ Operating free-air temperature	-55		125	0		70	°C

## **electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)**

PARAMETER	TEST CONDITIONS †	SN5437			SN7437			UNIT
		MIN	TYP ‡	MAX	MIN	TYP ‡	MAX	
$V_{IK}$	$V_{CC} = \text{MIN}, I_I = -12 \text{ mA}$			-1.5			-1.5	V
$V_{OH}$	$V_{CC} = \text{MIN}, V_{IL} = 0.8 \text{ V}, I_{OH} = -1.2 \text{ mA}$	2.4	3.3		2.4	3.3		V
$V_{OL}$	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, I_{OL} = 48 \text{ mA}$		0.2	0.4		0.2	0.4	V
$I_I$	$V_{CC} = \text{MAX}, V_I = 5.5 \text{ V}$			1			1	mA
$I_{IH}$	$V_{CC} = \text{MAX}, V_I = 2.4 \text{ V}$			40			40	µA
$I_{IL}$	$V_{CC} = \text{MAX}, V_I = 0.4 \text{ V}$			-1.6			-1.6	mA
$I_{OS} §$	$V_{CC} = \text{MAX}$	-20		-70	-18		-70	mA
$I_{CCH}$	$V_{CC} = \text{MAX}, V_I = 0 \text{ V}$		9	15.5		9	15.5	mA
$I_{CCL}$	$V_{CC} = \text{MAX}, V_I = 4.5 \text{ V}$		34	54		34	54	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at  $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$ .

§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

## **switching characteristics, $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$ (see note 2)**

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{PLH}$	A or B	Y	$R_L = 133 \Omega, C_L = 45 \text{ pF}$		13	22	ns
$t_{PHL}$					8	15	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

# **SN54LS37, SN74LS37** **QUADRUPLE 2-INPUT POSITIVE-NAND BUFFERS**

## **recommended operating conditions**

	SN54LS37			SN74LS37			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
$V_{CC}$ Supply voltage	4.5	5	5.5	4.75	5	5.25	V
$V_{IH}$ High-level input voltage	2			2			V
$V_{IL}$ Low-level input voltage			0.7			0.8	V
$I_{OH}$ High-level output current			-1.2			-1.2	mA
$I_{OL}$ Low-level output current			12			24	mA
$T_A$ Operating free-air temperature	-55		125	0		70	°C

## **electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)**

PARAMETER	TEST CONDITIONS †	SN54LS37			SN74LS37			UNIT
		MIN	TYP ‡	MAX	MIN	TYP ‡	MAX	
$V_{IK}$	$V_{CC} = \text{MIN}, I_I = -18 \text{ mA}$			-1.5			-1.5	V
$V_{OH}$	$V_{CC} = \text{MIN}, V_{IL} = \text{MAX}, I_{OH} = -1.2 \text{ mA}$	2.5	3.4		2.7	3.4		V
$V_{OL}$	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, I_{OL} = 12 \text{ mA}$		0.25	0.4		0.25	0.4	V
	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, I_{OL} = 24 \text{ mA}$					0.35	0.5	
$I_I$	$V_{CC} = \text{MAX}, V_I = 7 \text{ V}$			0.1			0.1	mA
$I_{IH}$	$V_{CC} = \text{MAX}, V_I = 2.7 \text{ V}$			20			20	µA
$I_{IL}$	$V_{CC} = \text{MAX}, V_I = 0.4 \text{ V}$			-0.4			-0.4	mA
$I_{OS} §$	$V_{CC} = \text{MAX}$	-30		-130	-30		-130	mA
$I_{CCH}$	$V_{CC} = \text{MAX}, V_I = 0 \text{ V}$		0.9	2		0.9	2	mA
$I_{CCL}$	$V_{CC} = \text{MAX}, V_I = 4.5 \text{ V}$		6	12		6	12	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at  $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$ .

§ Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

## **switching characteristics, $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$ (see note 2)**

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{PLH}$	A or B	Y	$R_L = 667 \Omega, C_L = 45 \text{ pF}$		12	24	ns
$t_{PHL}$					12	24	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

# **SN54S37, SN74S37** **QUADRUPLE 2-INPUT POSITIVE-NAND BUFFERS**

## recommended operating conditions

	SN54S37			SN74S37			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
V <sub>CC</sub> Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V <sub>IH</sub> High-level input voltage	2			2			V
V <sub>IL</sub> Low-level input voltage			0.8			0.8	V
I <sub>OH</sub> High-level output current			-3			-3	mA
I <sub>OL</sub> Low-level output current			60			60	mA
T <sub>A</sub> Operating free-air temperature	-55		125	0		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS †	SN54S37			SN74S37			UNIT
		MIN	TYP ‡	MAX	MIN	TYP ‡	MAX	
V <sub>IK</sub>	V <sub>CC</sub> = MIN, I <sub>I</sub> = -18 mA			-1.2			-1.2	V
V <sub>OH</sub>	V <sub>CC</sub> = MIN, V <sub>IL</sub> = 0.8 V, I <sub>OH</sub> = -3 mA	2.5	3.4		2.7	3.4		V
V <sub>OL</sub>	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, I <sub>OL</sub> = 60 mA			0.5			0.5	V
I <sub>I</sub>	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V			1			1	mA
I <sub>IH</sub>	V <sub>CC</sub> = MAX, V <sub>I</sub> = 2.7 V			0.1			0.1	mA
I <sub>IL</sub>	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.5 V			-4			-4	mA
I <sub>OS</sub> §	V <sub>CC</sub> = MAX	-50		-225	-50		-225	mA
I <sub>CCH</sub>	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0 V		20	36		20	36	mA
I <sub>CCL</sub>	V <sub>CC</sub> = MAX, V <sub>I</sub> = 4.5		46	80		46	80	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed 100 milliseconds.

## switching characteristics, V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	MAX	UNIT
t <sub>PLH</sub>	A or B	Y	R <sub>L</sub> = 93 Ω,	C <sub>L</sub> = 50 pF	4	6.5		ns
t <sub>PHL</sub>					4	6.5		ns
t <sub>PLH</sub>			R <sub>L</sub> = 93 Ω,	C <sub>L</sub> = 150 pF	6			ns
t <sub>PHL</sub>					6			ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

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